



August 2007  
**QFET**®

# FQA36P15 / FQA36P15\_F109

## 150V P-Channel MOSFET

### Features

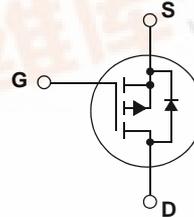
- 36A, -150V,  $R_{DS(on)} = 0.09\Omega @ V_{GS} = -10V$
- Low gate charge ( typical 81 nC)
- Low Crss ( typical 110pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- 175°C maximum junction temperature rating



### Description

These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies, active power factor correction, electronic lamp ballast based on half bridge topology.



### Absolute Maximum Ratings

Symbol	Parameter	FQA36P15	Units
$V_{DSS}$	Drain-Source Voltage	-150	V
$I_D$	Drain Current - Continuous ( $T_C = 25^\circ C$ )	-36	A
	- Continuous ( $T_C = 100^\circ C$ )	-25.5	A
$I_{DM}$	Drain Current - Pulsed (Note 1)	-144	A
$V_{GSS}$	Gate-Source Voltage	$\pm 30$	V
$E_{AS}$	Single Pulsed Avalanche Energy (Note 2)	1400	mJ
$I_{AR}$	Avalanche Current (Note 1)	-36	A
$E_{AR}$	Repetitive Avalanche Energy (Note 1)	29.4	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	-5.0	V/ns
$P_D$	Power Dissipation ( $T_C = 25^\circ C$ )	294	W
	- Derate above $25^\circ C$	1.96	W/ $^\circ C$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +175	$^\circ C$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ C$

### Thermal Characteristics

Symbol	Parameter	Typ	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	--	0.51	$^\circ C/W$
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink	0.24	--	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	--	40	$^\circ C/W$



## Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FQA36P15	FQA36P15	TO-3P	--	--	30
FQA36P15	FQA36P15_F109	TO-3PN	--	--	30

## Electrical Characteristics T<sub>C</sub> = 25°C unless otherwise noted

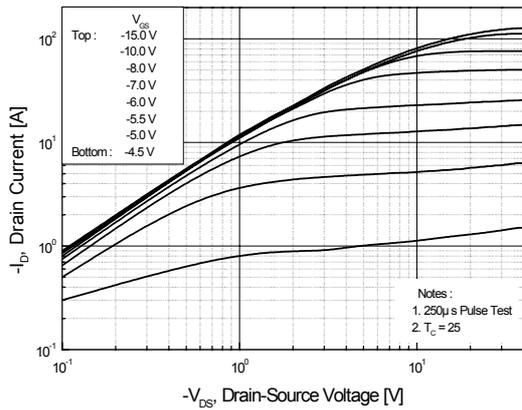
Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = -250 μA	-150	--	--	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = -250 μA, Referenced to 25°C	--	-0.13	--	V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -150 V, V <sub>GS</sub> = 0 V	--	--	-10	μA
		V <sub>DS</sub> = -120 V, T <sub>C</sub> = 150°C	--	--	-100	μA
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = -25 V, V <sub>DS</sub> = 0 V	--	--	-100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = 25 V, V <sub>DS</sub> = 0 V	--	--	100	nA
<b>On Characteristics</b>						
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250 μA	-2.0	--	-4.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = -10 V, I <sub>D</sub> = -18A	--	0.076	0.09	Ω
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = -40 V, I <sub>D</sub> = -18A (Note 4)	--	19.5	--	S
<b>Dynamic Characteristics</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = -25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz	--	2550	3320	pF
C <sub>oss</sub>	Output Capacitance		--	710	920	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		--	110	140	pF
<b>Switching Characteristics</b>						
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = -75 V, I <sub>D</sub> = -36A, R <sub>G</sub> = 25 Ω  (Note 4, 5)	--	50	110	ns
t <sub>r</sub>	Turn-On Rise Time		--	350	710	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		--	155	320	ns
t <sub>f</sub>	Turn-Off Fall Time		--	150	310	ns
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> = -120 V, I <sub>D</sub> = -36A, V <sub>GS</sub> = -10 V  (Note 4, 5)	--	81	105	nC
Q <sub>gs</sub>	Gate-Source Charge		--	19	--	nC
Q <sub>gd</sub>	Gate-Drain Charge		--	42	--	nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current		--	--	-36	A
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current		--	--	-144	A
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = -36A	--	--	-4.0	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>S</sub> = -36 A, dI <sub>F</sub> / dt = 100 A/μs  (Note 4)	--	198	--	ns
Q <sub>rr</sub>	Reverse Recovery Charge		--	1.45	--	μC

### NOTES:

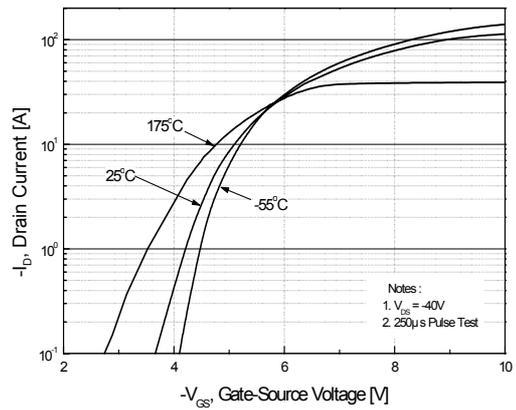
1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. L = 1.45mH, I<sub>AS</sub> = -36A, V<sub>DD</sub> = -50V, R<sub>G</sub> = 25 Ω, Starting T<sub>J</sub> = 25°C
3. I<sub>SD</sub> ≤ -36A, di/dt ≤ 300A/μs, V<sub>DD</sub> ≤ BV<sub>DSS</sub>, Starting T<sub>J</sub> = 25°C
4. Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2%
5. Essentially independent of operating temperature

## Typical Performance Characteristics

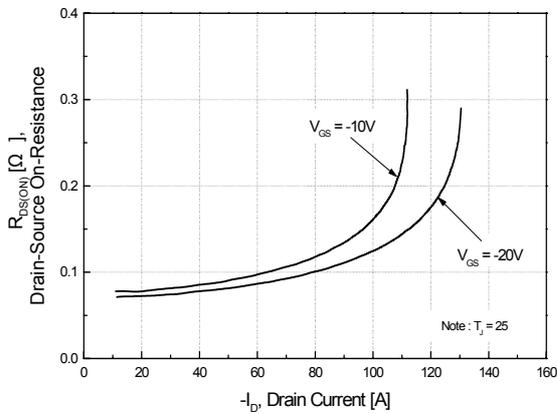
**Figure 1. On-Region Characteristics**



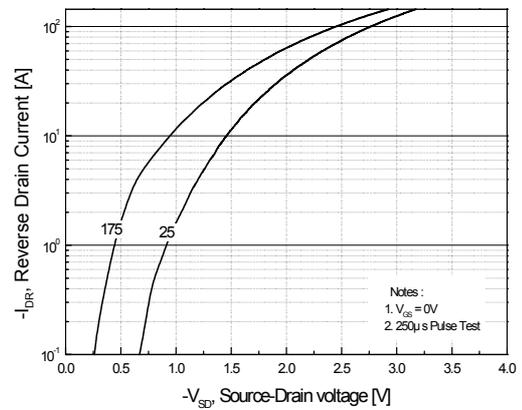
**Figure 2. Transfer Characteristics**



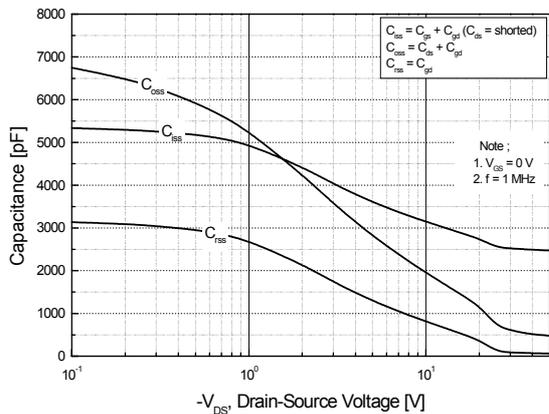
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



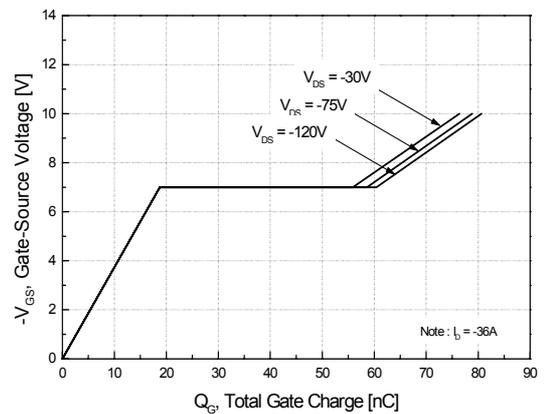
**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**



**Figure 5. Capacitance Characteristics**

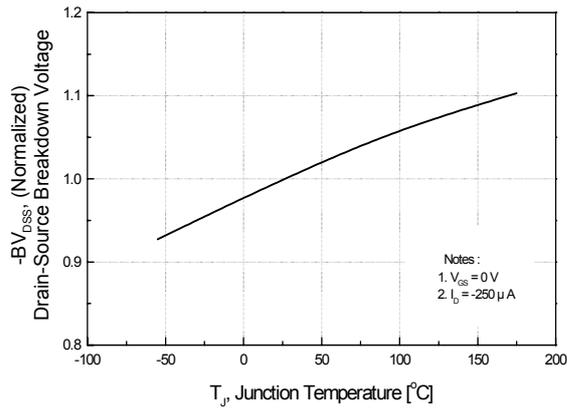


**Figure 6. Gate Charge Characteristics**

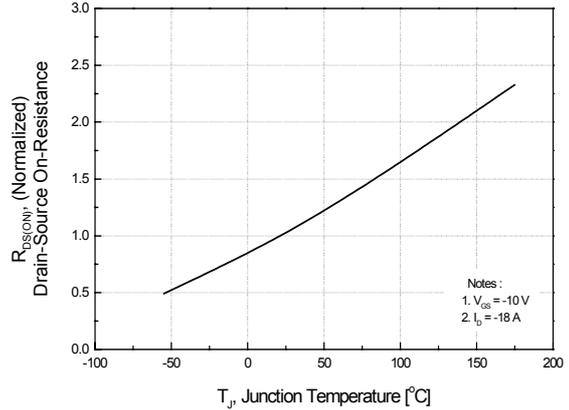


**Typical Performance Characteristics** (Continued)

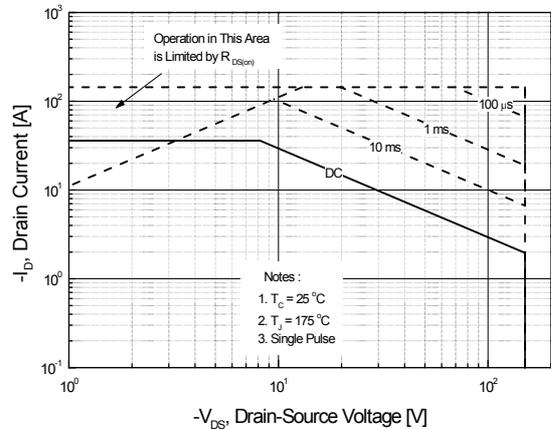
**Figure 7. Breakdown Voltage Variation vs. Temperature**



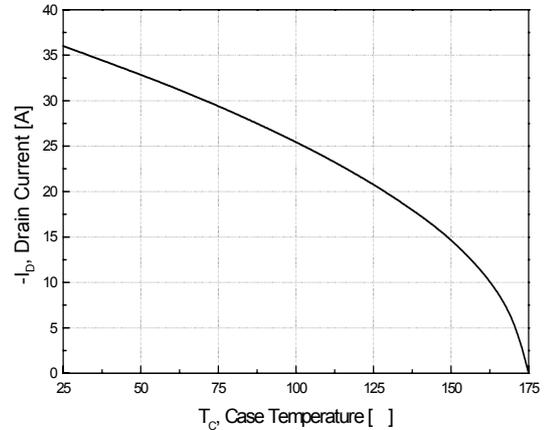
**Figure 8. On-Resistance Variation vs. Temperature**



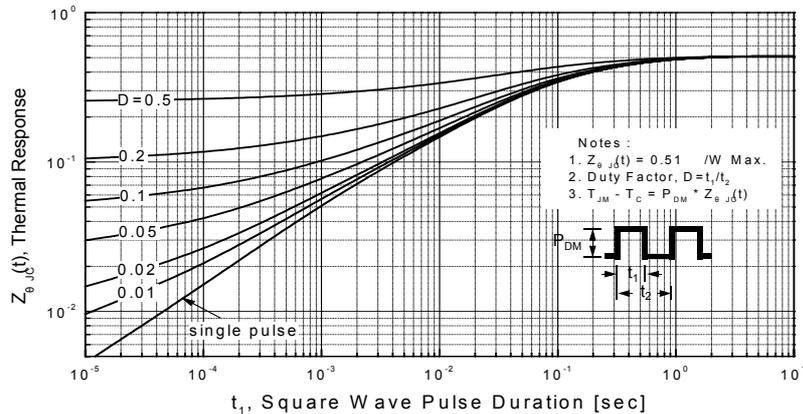
**Figure 9. Maximum Safe Operating Area**



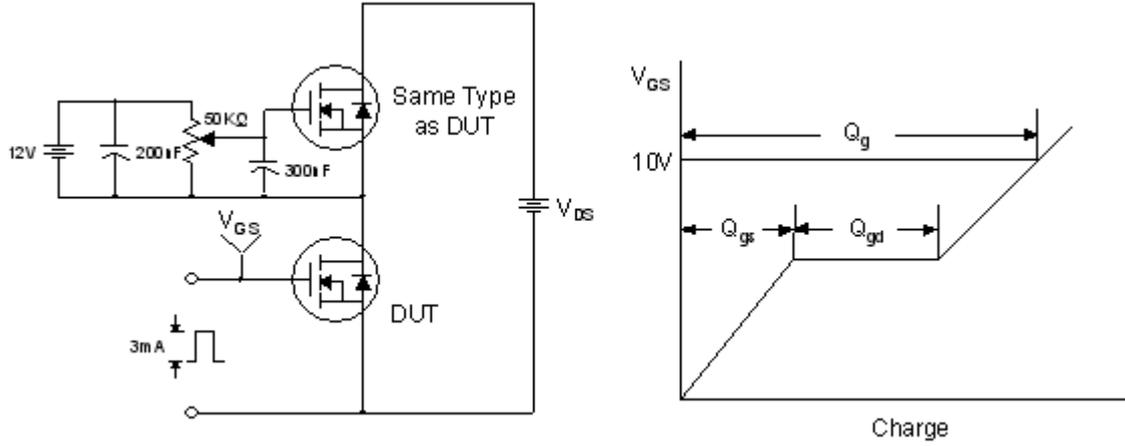
**Figure 10. Maximum Drain Current vs. Case Temperature**



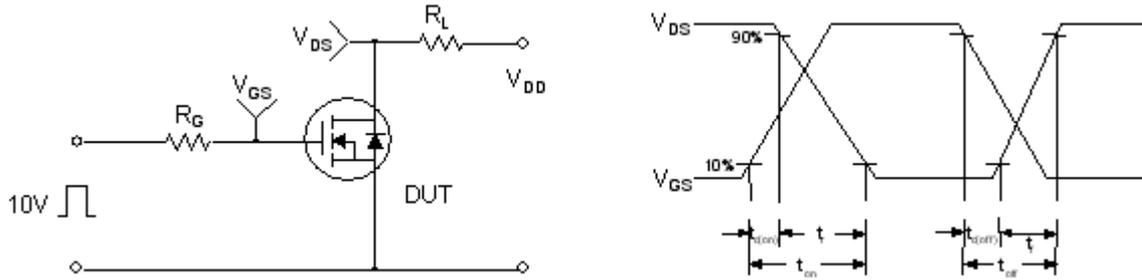
**Figure 11. Transient Thermal Response Curve**



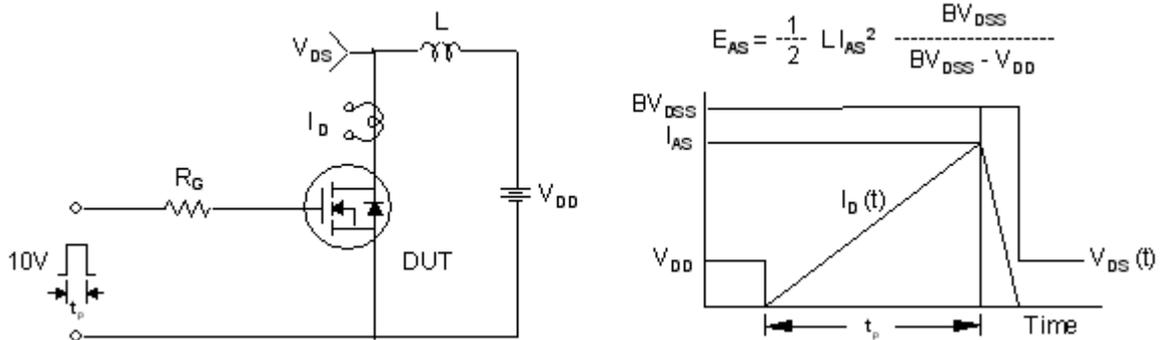
**Gate Charge Test Circuit & Waveform**



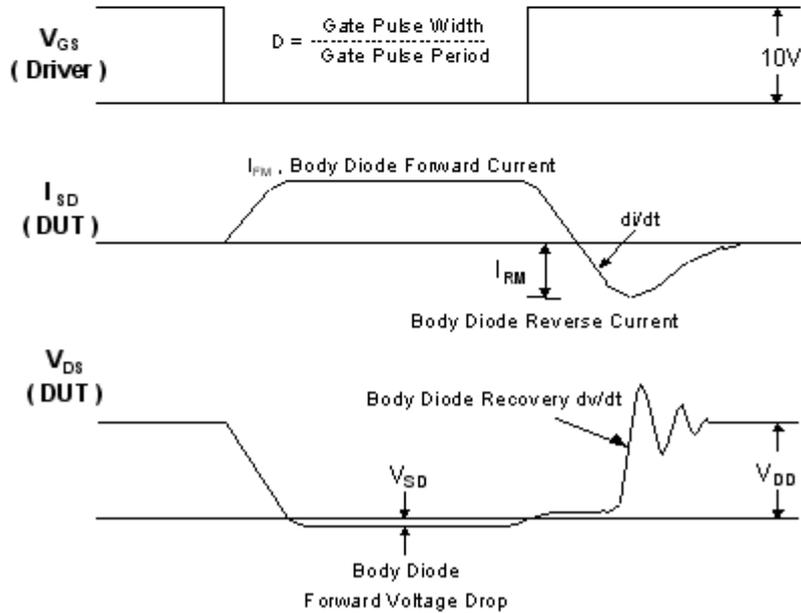
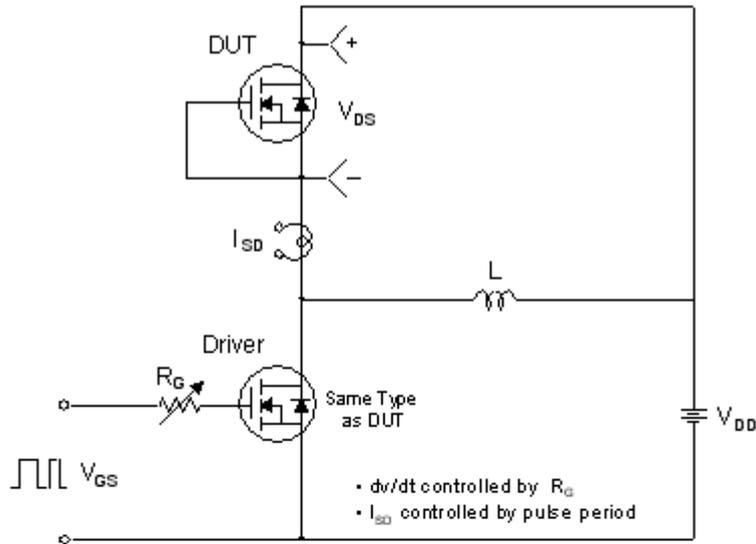
**Resistive Switching Test Circuit & Waveforms**



**Unclamped Inductive Switching Test Circuit & Waveforms**

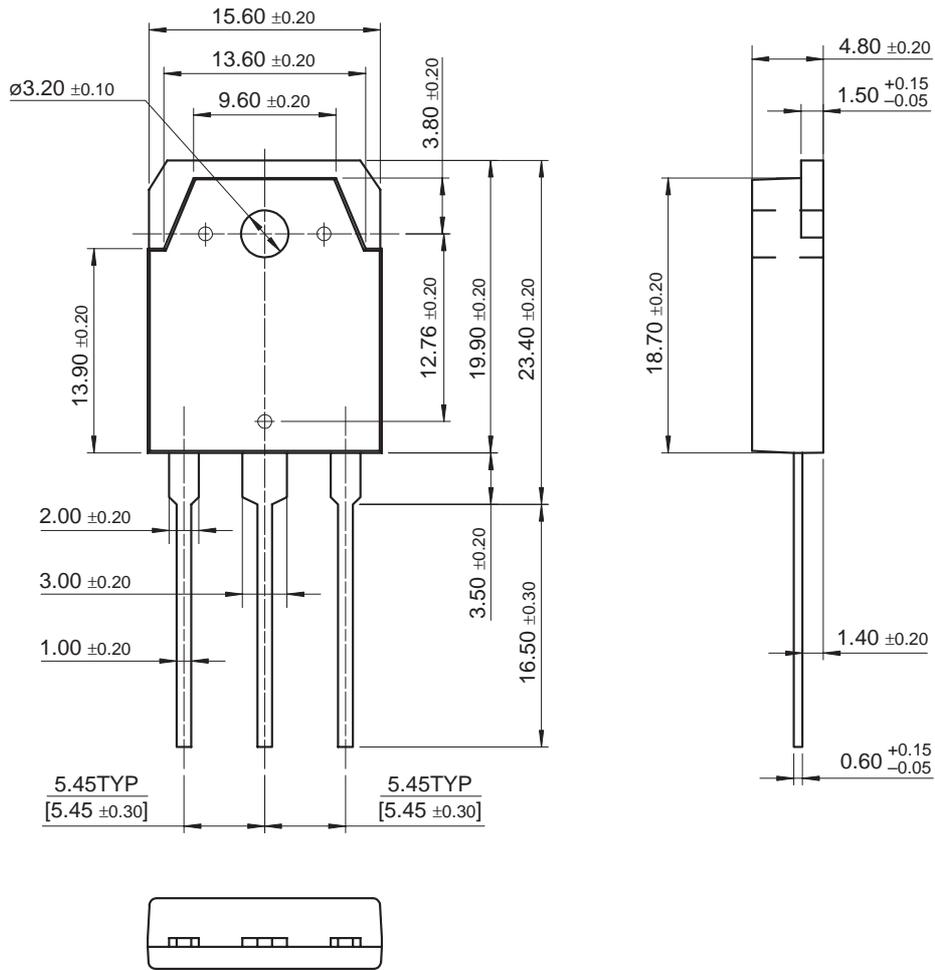


Peak Diode Recovery dv/dt Test Circuit & Waveforms



Mechanical Dimensions

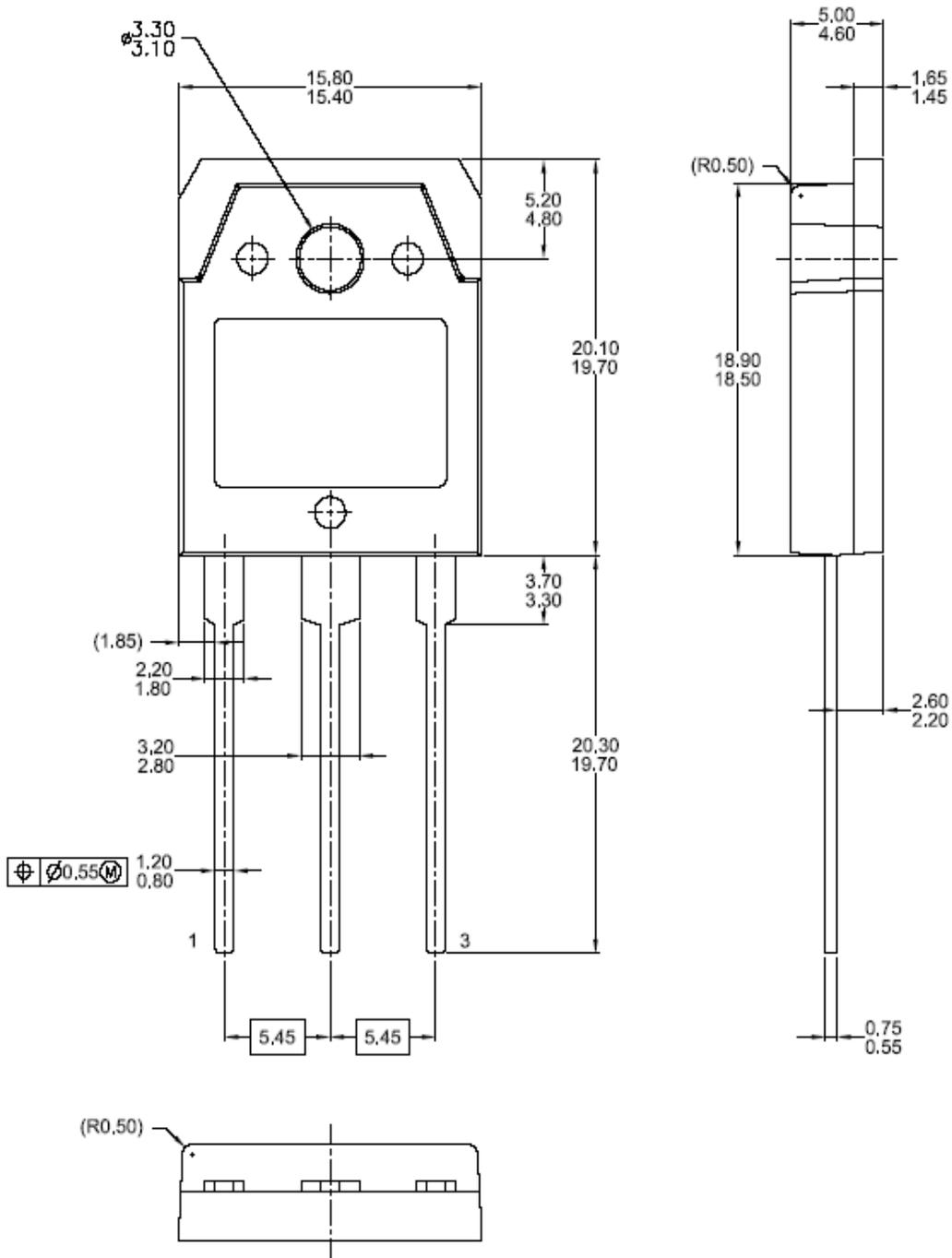
TO-3P



Dimensions in Millimeters

**Mechanical Dimensions** (Continued)

**TO-3PN**



Dimensions in Millimeters



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